



Beam dynamics and optics issues

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for the ERL beam dynamics working group

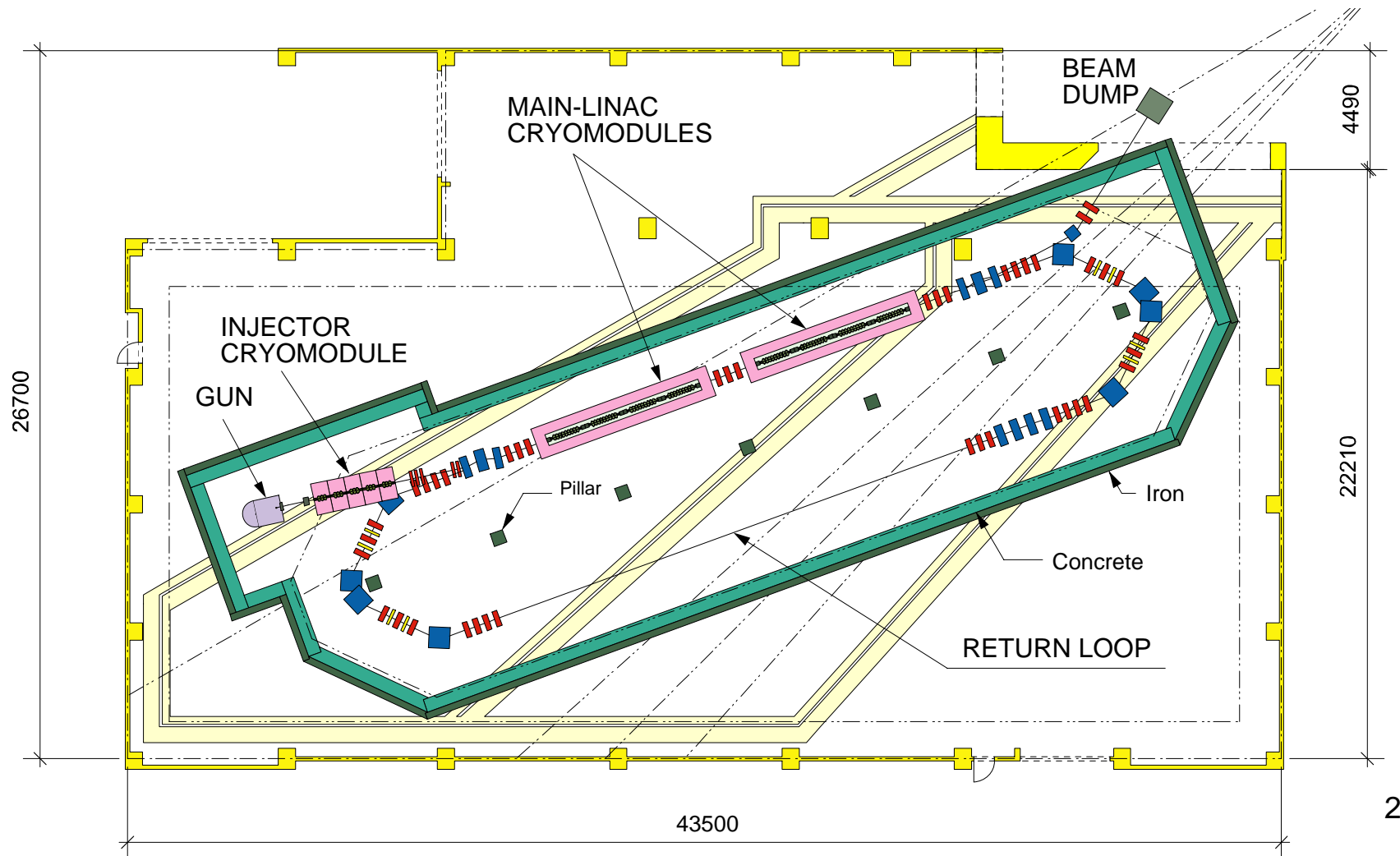
Mini-Workshop for ERL under the collaboration meeting between
CLASSE and KEK, March 12, 2007, at Cornell University

Planned ERL test facility

Cold neutron
building version

Maximum current: 100 mA
Beam energy: 60 – (200) MeV

Normalized emittance: 1 – 0.1 mm·mrad
Injection energy: 5 MeV (10-15 MeV)



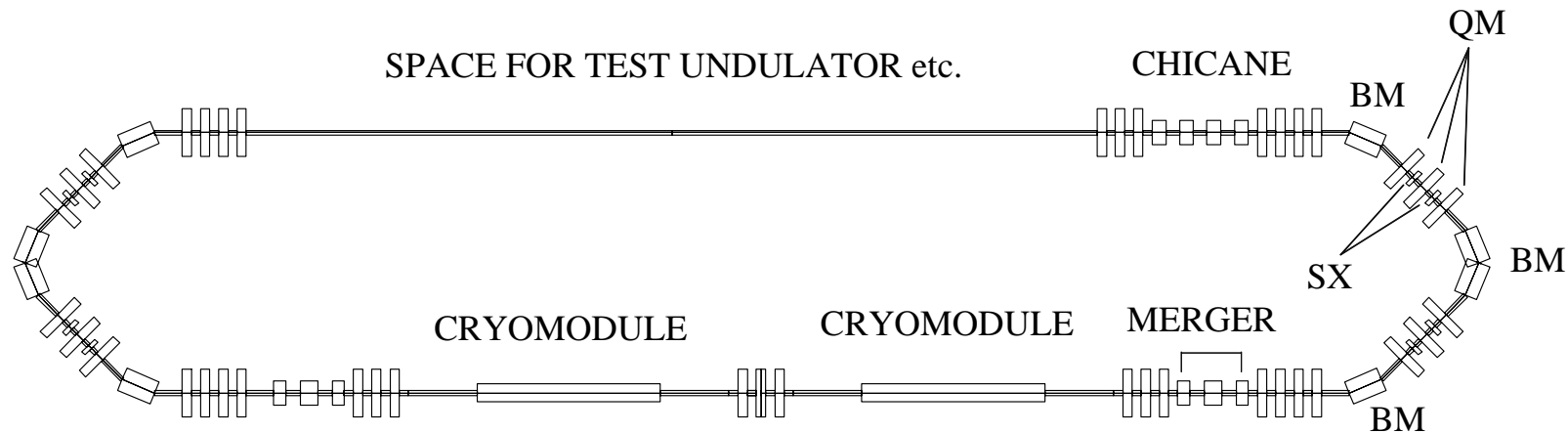
Beam dynamics issues

- Beam optics in the recirculation pass
 - Linear & non-linear optics issues
 - Bunch compression scheme
 - Collective effects due to CSR → not yet
- Beam instabilities *etc.*
 - BBU due to cavity HOMs → Sawamura's talk
 - Resistive-wall multibunch BBU
 - Ion trapping
 - Beam loss mechanism → not yet
- Injector simulations for design optimization
 - Multi-parameter optimization algorithms → under preparation

Beam optics in return loop

Lattice under consideration (TBA)

K. Harada, Y. Kobayashi (KEK)

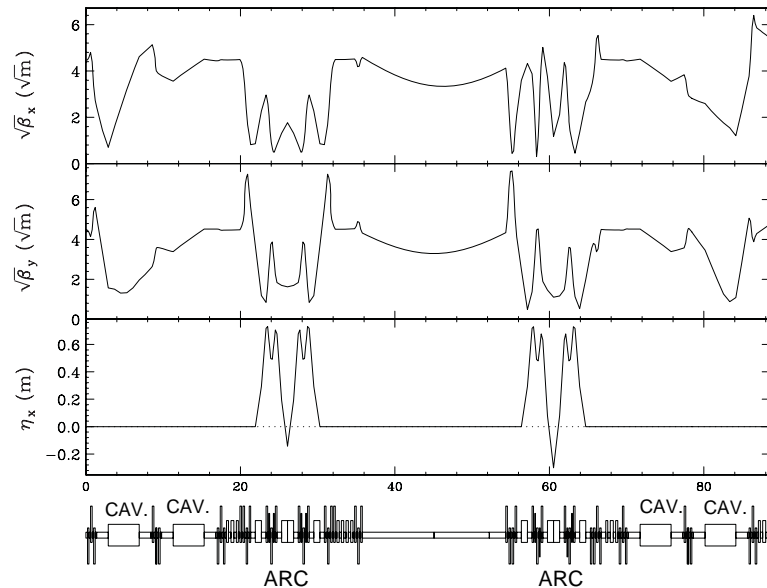


Design issues

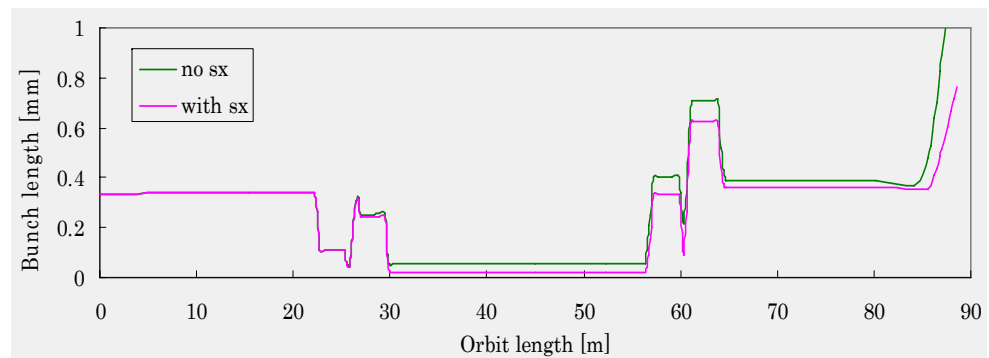
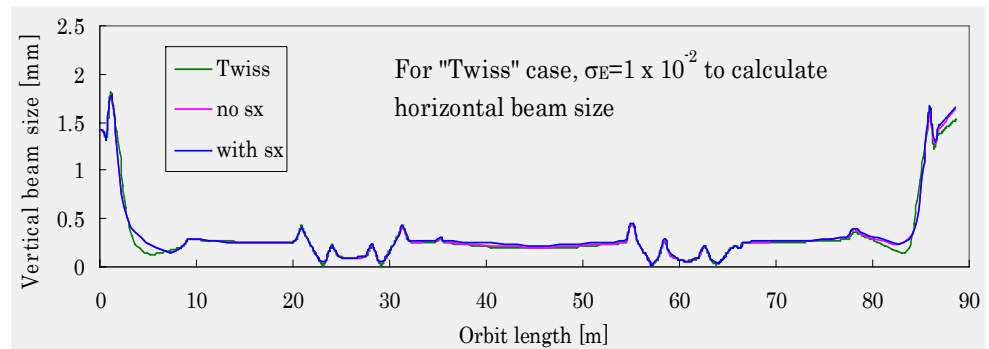
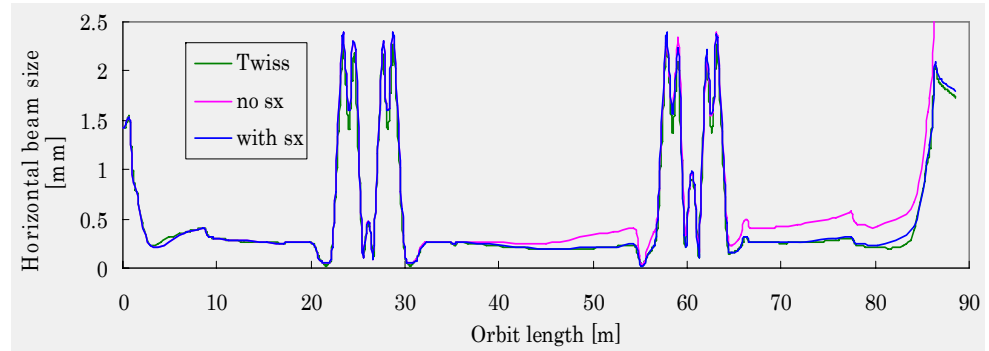
- Similar lattice to that of 5-GeV ERL.
- Minimize emittance growth due to CSR etc.
- Adjustable R_{56} for bunch compression (B.C.)
- Minimizing bunch length under B.C.
- Adjustable circumference for energy recovery
- x-y coupling control for BBU study
- Able to install undulators
- etc.

Linear optics and beam sizes (for B.C.; preliminary)

Off-crest acceleration $\phi=70$ deg. ($5 \rightarrow 155$ MeV) , $\sigma_\tau = 1$ ps, $\sigma_E = 1 \times 10^{-4}$,
 $\varepsilon_{n(x,y)} = 1$ mm·mrad



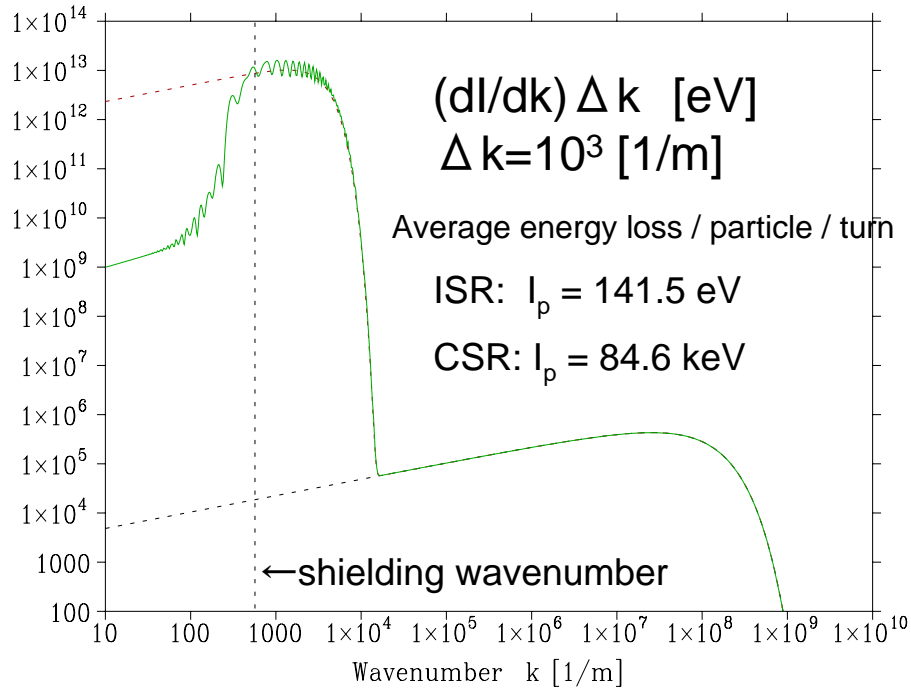
- Due to large correlated energy spread, chromaticity corrections are essential.
- The beam distribution has a halo, which will lead to beam losses. More optimization of beam optics is necessary.
- (CSR effects are not included)



CSR in the Arcs

T. Agoh (KEK)

Radiation spectrum



$E = 200$ MeV

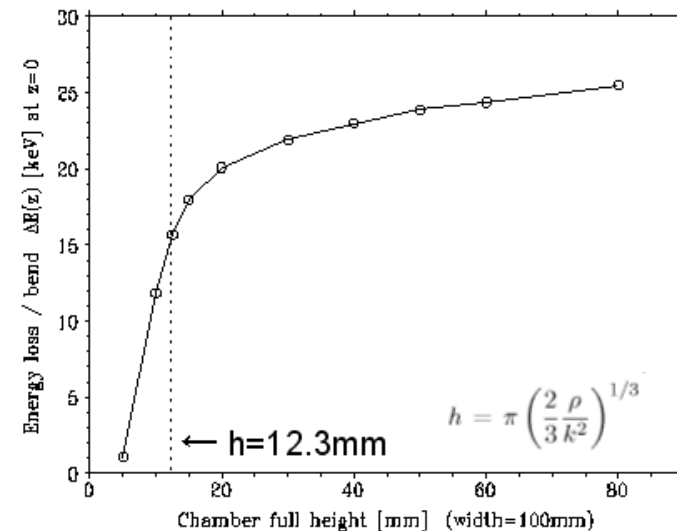
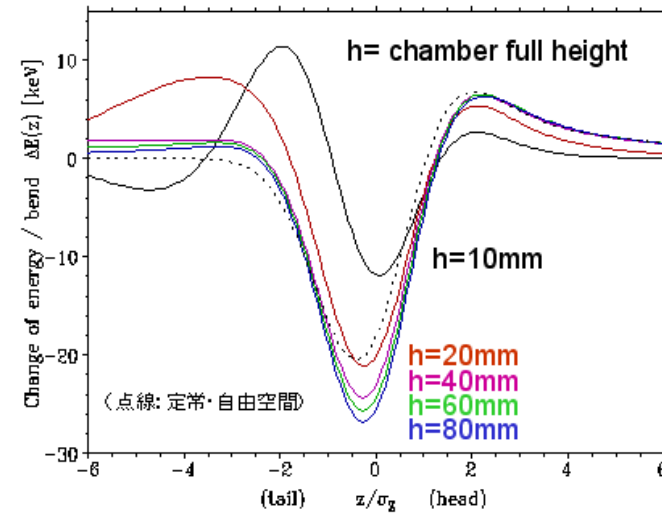
$eN_e = 77$ pC ($N = 4.8 \times 10^8$)

$\sigma_\tau = 1$ ps (Gaussian distribution)

Bend: $\rho = 1$ m, 60 deg. $\times 6$

Vac.chamber: 100mm \times 40mm (Cu)

Shielding effect (using mesh code)



Resistive-wall multi-bunch BBU

N. Nakamura
(Univ. Tokyo)

- Resistive-wall wakes due to vacuum chambers may cause transverse beam breakup instability.
- Transverse RW wake depends strongly on the aperture:
 - An important factor for determining the aperture.
- Growth times were estimated analytically using simplified model.

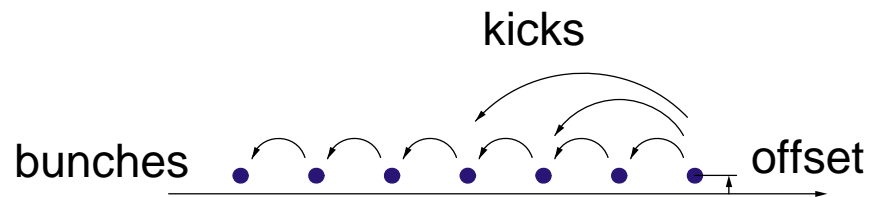
$$W_{\perp} \propto \frac{1}{b^3}$$

Transverse kick of resistive-wall wake

- Kick angle due to resistive-wall wake per bunch

$$\Delta\theta_y = -\frac{e^2 N}{E} W_{\perp} \cdot y = \frac{e^2 N}{E} \cdot \frac{cL}{\pi b^3 z^{1/2}} \sqrt{\frac{Z_0}{\pi\sigma_c}} \cdot y$$

N : Number of electrons per bunch E : Beam energy



Equation of motion

Equation of motion for an particle in the M -th bunch

$$y_M''(s) + k_y^2 y_M(s) = \sum_{N=0}^{M-1} S(M-N) y_N(s)$$

$$S(M) = \frac{a}{\sqrt{M}}, \quad a \equiv \frac{e^2 N}{E} \cdot \frac{c}{\pi b^3 (c\tau_B)^{1/2}} \sqrt{\frac{Z_0}{\pi\sigma_c}} = \frac{4I_B}{I_A} \frac{\delta_{skin}}{b^3}$$

$$I_B = \frac{eN}{\tau_B}, \quad I_A = \frac{4\pi\epsilon_0 mc^3 \gamma}{e}, \quad \delta_{skin} = \sqrt{\frac{\tau_B}{\pi\mu_0\sigma_c}}$$

τ_B : bunch separation in unit of seconds k_y : external focusing

s : position of resistive-wall pipe, $s=0$ at the entrance

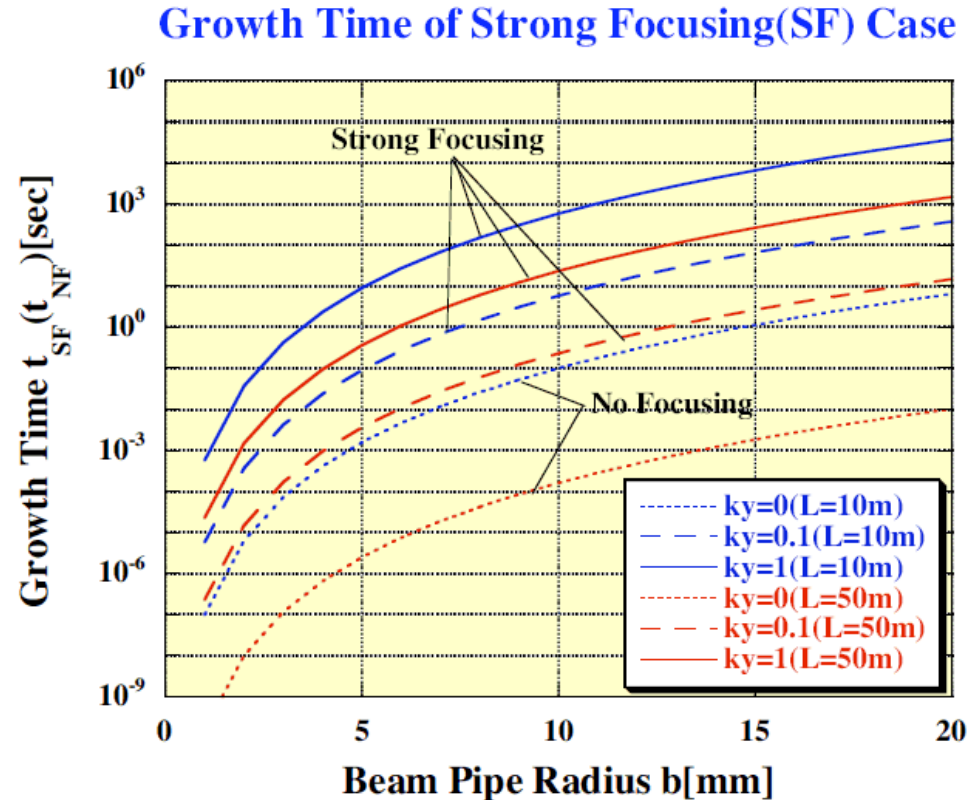
Asymptotic solution for $M \rightarrow \infty$ ($M \sim t/\tau_B$)

(J. M. Wang and J. Wu, PRST-AB 7, 034402(2004))

Resistive-wall multi-bunch BBU

Results of SF case (1)

N. Nakamura
(Univ. Tokyo)



$$t_{SF} \propto k_y^2 b^6 L^{-2} \quad (t_{NF} \propto b^6 L^{-4})$$

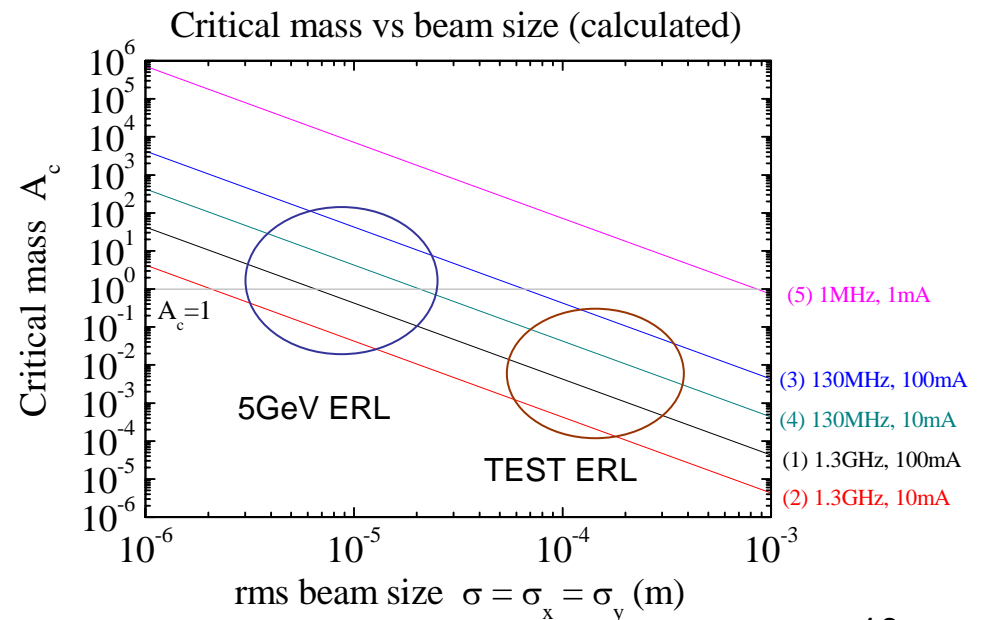
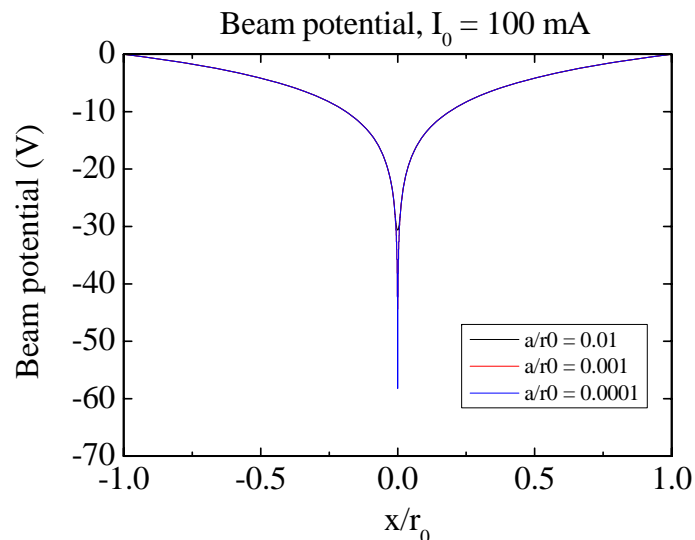
- $E = 200$ MeV, $I_0 = 100$ mA
- Wall material: aluminum

- Some feedbacks may be required for suppressing the instability.
- Simulation study is underway under more realistic situation.

Ion trapping

S. Sakanaka (KEK)

- Ion trapping may cause large betatron-phase errors or fast ion instabilities.
 - Ref: G. Hoffstaetter, M. Liepe: Nucl. Instrum. Methods A **557** (2006) 205.
- Cures should be considered in advance.
 - Clearing electrode (in above ref.)
 - Bunch gap (not promising?) → investigated further
 - Beam-size modulation

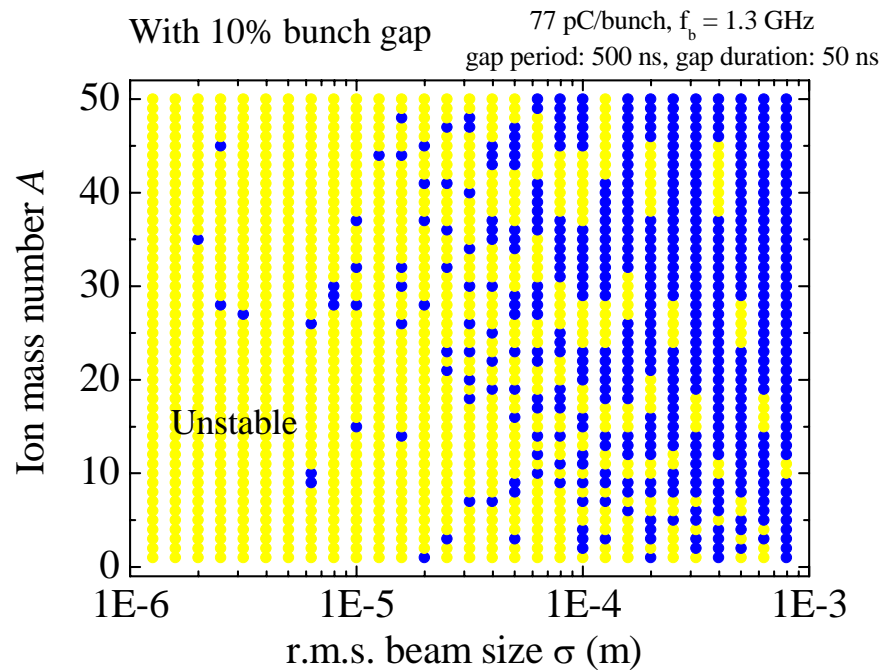


Effect of bunch gap (ion trapping)

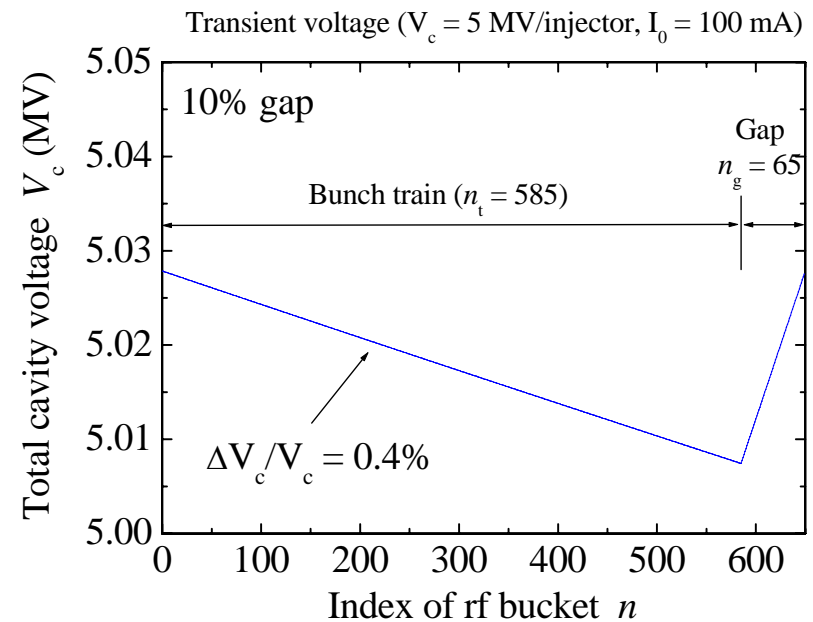
S. Sakanaka (KEK)

- Bunch gap with high repetition frequency: 2 MHz, 10% gap
- Assumed five 2-cell cavities, $R_{sh}/Q = 200 \Omega/\text{cavity}$, $V_c=5 \text{ MV}$, 100 mA
- Transient voltage variation may be acceptable:
- Feedforward compensation seems possible.

$$\frac{\Delta V_c}{V_c} \approx \frac{\omega_{res} (R_{sh}/Q) q_b n_t n_g}{2V_c n_p}$$



Stability of ions

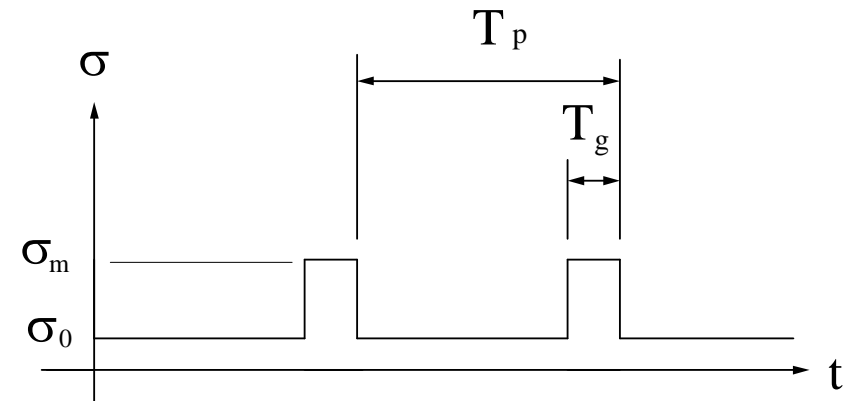
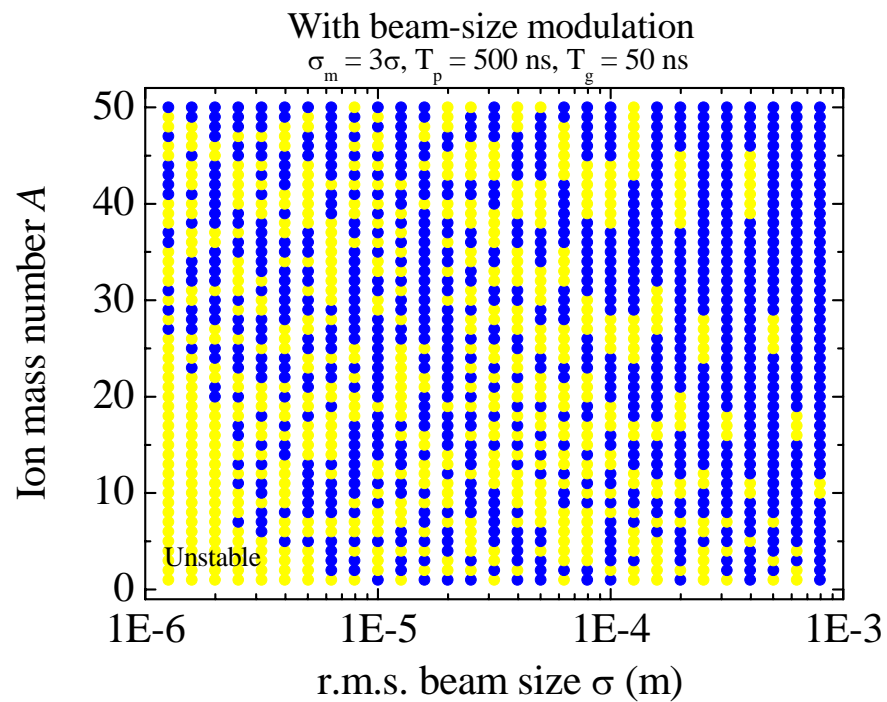


Bunch gap transient 11

Effect of beam-size modulation

S. Sakanaka (KEK)

- Beam size modulation will result in the similar effect to the bunch gap.
- No rf transients in the injector cavities.
- Example of modulation: $\sigma_m = 3\times\sigma_0$, 10% duty factor, 2 MHz repetition.



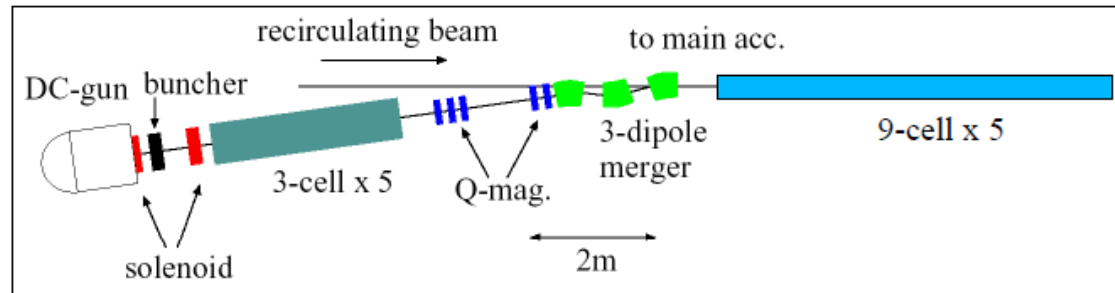
Beam size modulation

Stability of ions

Starting point for injector design

Design made by JAEA group

R. Hajima et al., NIM-A557, 103-105 (2006)

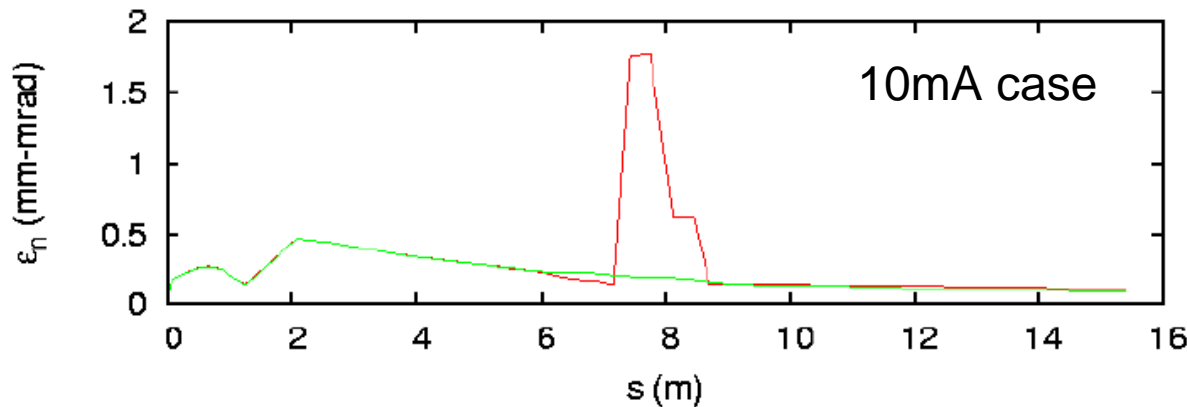


Gun voltage : 500kV
Injection energy: 5MeV

Multi-parameter optimization with simulated annealing (SA) and downhill simplex algorithms.



Simulation result (ϵ_n)
1mm·mrad (100mA)
0.1mm·mrad (10mA)



Further optimization is underway by referring Cornell design

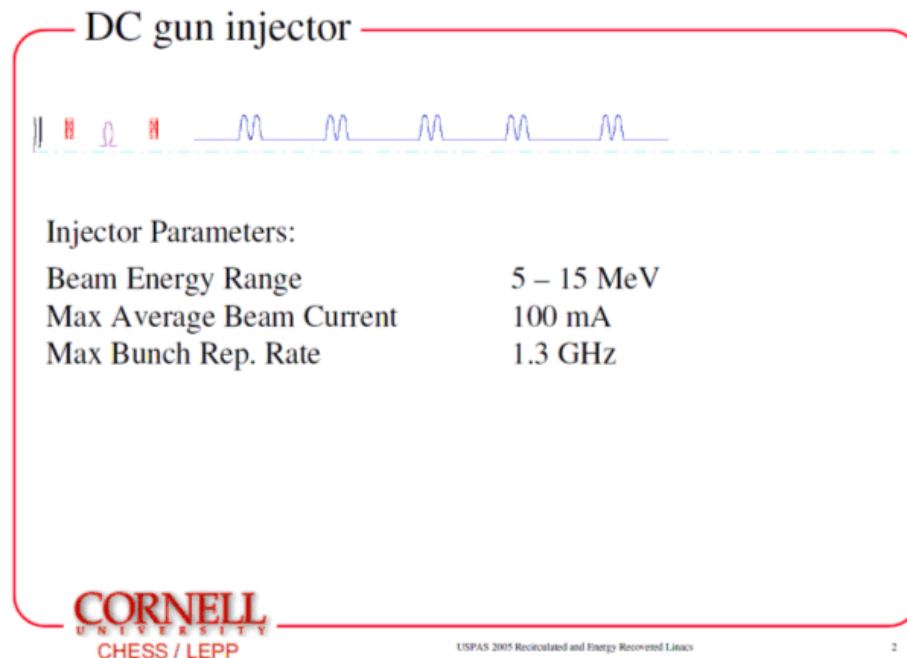
$$\epsilon_n \sim 0.1 \text{ mm}\cdot\text{mrad} (\sim 100 \text{ mA}; 0.1 \text{ nC/bunch})$$

(cf.) I.V. Bazarov and C.K. Sinclair, Phys. Rev. ST Accel. Beams **8**, 034202 (2005).

Toward further optimization

Reproduction of Cornell simulations (Astra)

T. Miyajima (KEK)



Configurations

- DC photocathode
- Solenoid + buncher + solenoid
- Five 2-cell cavities
- 80 pC/bunch
- Without any quadrupoles
- 8.56 m to exit

Courtesy: Dr. I. Bazarov.

- $\epsilon_{nx} = 1.11$ mm·mrad (Cornell: 0.82) at gun voltage of 500 kV
- $\epsilon_{nx} = 0.29$ mm·mrad (Cornell: 0.14) at gun voltage of 750 kV
- Scripts of the optimization algorithms are under preparation.

Toward further optimization

Dependence of emittance on the first-cavity voltage

T. Miyajima (KEK)

Case (1)

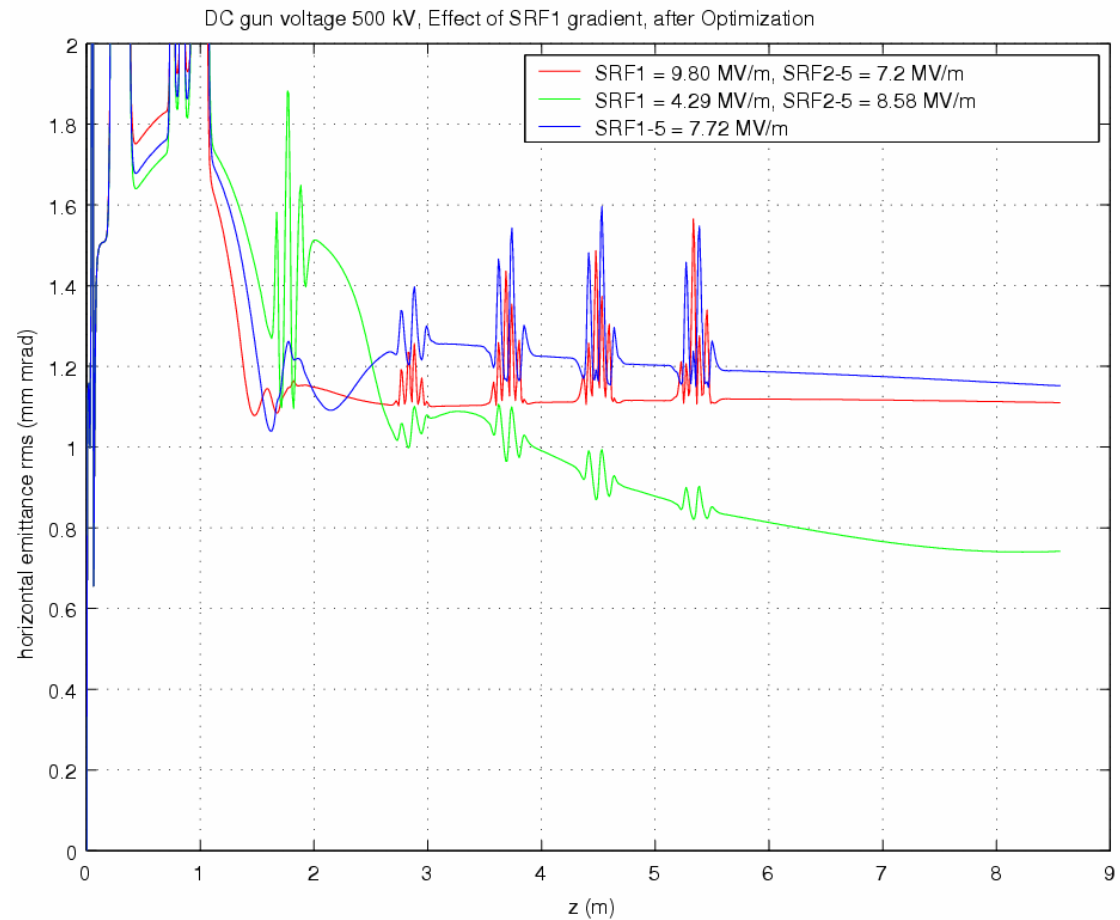
- SRF1 = 9.80 MV/m, SRF2-5=7.20 MV/m
- $\epsilon_{nx} = 1.11 \text{ mm}\cdot\text{mrad}$

Case (2)

- SRF1 = 4.29 MV/m, SRF2-5=8.58 MV/m
- $\epsilon_{nx} = 0.74 \text{ mm}\cdot\text{mrad}$

Case (3)

- SRF1-5 = 7.72 MV/m,
- $\epsilon_{nx} = 1.15 \text{ mm}\cdot\text{mrad}$



Low rf voltage of the first cavity yielded a lower emittance.

Injector issues to be investigated

Suggestions about the following issues are very welcome.

- Requirement for Q-values of HOMs at injector SC cavities.
 - Simulation study is under consideration.
 - Are there any studies at Cornell?
- Contribution of each effect to the emittance growth.
 - Space charge, RF kicks, CSR at merger *etc.*
 - Is it possible to understand each effect separately ?
 - What are the key issues?
- Constitution of the power source.
 - Is it acceptable to drive several cavities by a single klystron?
- Other potential (might be minor) causes for beam degradations.
 - Wakefields in the gun chamber
 - Wakefields at the beam collimator for removing beam tails
 - Ion trapping, *etc.*

Summary

- Lattice design & single-particle optics calculations for the ERL test facility
 - Need more optimizations
 - Collective effects due to CSR are not included yet
- Prediction of HOM-BBU thresholds (Sawamura's talk)
 - For newly designed ERL cavity & for TESLA cavity
 - Very promising
- Investigation on the resistive-wall multibunch BBU
 - Simulation study is underway
- Possible cures for ion trapping
- Preliminary design of injector.
 - Need much optimizations.
 - Suggestions are very welcome